

### **Features**

- 600V, 5A, Low V<sub>CE(sat)</sub>
- Trench-Gate Field-Stop technology
- Optimized for conduction
- Robust
- RoHS compliant\*

## **Applications**

- Switch-Mode Power Supplies (SMPS)
- Uninterruptible Power Sources (UPS)
- Power Factor Correction (PFC)

# **BIDD05N60T Insulated Gate Bipolar Transistor (IGBT)**

### **General Information**

The Bourns® Model BIDD05N60T IGBT device combines technology from a MOS gate and a bipolar transistor for an optimum component for high voltage and high current applications. This device uses Trench-Gate Field-Stop technology providing greater control of dynamic characteristics with a lower Collector-Emitter Saturation Voltage (V<sub>CE(sat)</sub>) and fewer switching losses. In addition, this structure improves the robustness of the device.

### **Additional Information**

Click these links for more information:











PRODUCT

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CONTACT

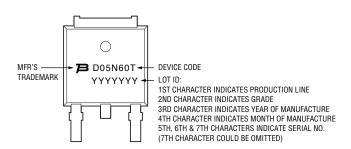
### Maximum Electrical Ratings (T<sub>C</sub> = 25 °C, unless otherwise specified)

Parameter	Symbol	Value	Unit
Collector-Emitter Voltage	V <sub>CES</sub>	600	V
Continuous Collector Current (T <sub>C</sub> = 25 °C), limited by T <sub>jmax</sub>	Ic	10	A
Continuous Collector Current (T <sub>C</sub> = 100 °C), limited by T <sub>jmax</sub>	Ic	5	A
Pulsed Collector Current, t <sub>p</sub> limited by T <sub>jmax</sub>	I <sub>CP</sub>	15	A
Gate-Emitter Voltage	V <sub>GE</sub>	±30	V
Continuous Forward Current (T <sub>C</sub> = 25 °C), limited by T <sub>jmax</sub>	l <sub>F</sub>	10	A
Short-circuit Withstand Time (V <sub>CE</sub> = 300 V, V <sub>GE</sub> = 15 V)	T <sub>SC</sub>	10	μs
Total Power Dissipation	P <sub>total</sub>	82	W
Storage Temperature	T <sub>STG</sub>	-55 to +150	°C
Operating Junction Temperature	Tj	-55 to +150	°C

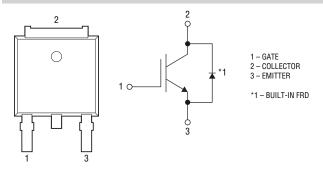
### **Thermal Resistance**

Parameter	Symbol	Max	Unit
IGBT Thermal Resistance Junction - Case	R <sub>th(j-c)_IGBT</sub>	1.51	°C/W
Diode Thermal Resistance Junction - Case	R <sub>th(j-c)_Diode</sub>	2.14	°C/W

### **Typical Part Marking**



### **Internal Circuit**





### Static Electrical Characteristics (T<sub>C</sub> = 25 °C, Unless Otherwise Specified)

Parameter	Symbol	Conditions	Value			11
Parameter			Min.	Тур.	Max.	Unit
Collector-Emitter Breakdown Voltage	BV <sub>CES</sub>	$V_{GE} = 0 \text{ V, } I_{C} = 250 \mu\text{A}$	600	_	_	V
Collector-Emitter Saturation Voltage	V <sub>CE(sat)</sub>	$V_{GE} = 15 \text{ V}, I_{C} = 5 \text{ A}$ $T_{C} = 25 \text{ °C}$	_	1.5	2.0	V
		V <sub>GE</sub> = 15 V, I <sub>C</sub> = 5 A T <sub>C</sub> = 125 °C	_	1.7	_	
Diada Famuard On Valtana	V <sub>F</sub>	I <sub>F</sub> = 5 A, T <sub>C</sub> = 25 °C	_	1.3	1.8	V
Diode Forward On-Voltage		I <sub>F</sub> = 5 A, T <sub>C</sub> = 125 °C	_	1.1	_	V
Gate Threshold Voltage	V <sub>GE(th)</sub>	$V_{CE} = V_{GE}, I_{C} = 250 \mu\text{A}$	3.5	5.5	6.5	V
Collector Cut-off Current	I <sub>CES</sub>	V <sub>GE</sub> = 0 V, V <sub>CE</sub> = 600 V	_	_	200	μΑ
Gate-Emitter Leakage Current	I <sub>GES</sub>	$V_{CE} = 0 \text{ V}, V_{GE} = \pm 20 \text{ V}$	_	_	±400	nA

### Dynamic Electrical Characteristics (T<sub>C</sub> = 25 °C, Unless Otherwise Specified)

Parameter	Cumbal	0	Value			Unit
	Symbol	Conditions	Min.	Тур.	Max.	Offic
Input Capacitance	C <sub>ies</sub>	V <sub>CE</sub> = 30 V, V <sub>GE</sub> = 0 V, f = 1 MHz	_	340	_	
Output Capacitance	C <sub>oes</sub>		_	26	_	pF
Reverse Transfer Capacitance	C <sub>res</sub>		_	7.6	_	
Total Gate Charge	Qg		_	18.5	_	
Gate-Emitter Charge	Q <sub>ge</sub>	$V_{CE} = 400 \text{ V}, V_{GE} = 15 \text{ V}$ $I_{C} = 5.0 \text{ A}$	_	5.1	_	nC
Gate-Collector Charge	Q <sub>gc</sub>	3.071	_	8.6	_	

### IGBT Switching Characteristics (Inductive Load, T<sub>C</sub> = 25 °C, unless otherwise specified)

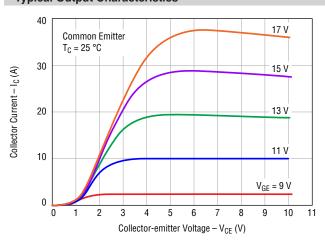
Parameter (T <sub>C</sub> = 25 °C)	Symbol	Conditions	Value			Unit
			Min.	Тур.	Max.	Oilit
Turn-on Delay Time	t <sub>d(on)</sub>	$V_{CE} = 400 \text{ V}, V_{GE} = 15 \text{ V}$ $I_{C} = 5.0 \text{ A}, R_{G} = 10 \Omega$	_	7	_	ns
Current Rise Time	t <sub>r</sub>		_	14	_	ns
Turn-off Delay Time	t <sub>d(off)</sub>		_	18	_	ns
Current Fall Time	t <sub>f</sub>		_	145	_	ns
Turn-on Switching Energy	E <sub>on</sub>		_	0.2	_	mJ
Turn-off Switching Energy	E <sub>off</sub>		_	0.07	_	mJ
Total Switching Energy	E <sub>ts</sub>		_	0.27	_	mJ

### Diode Switching Characteristics (T<sub>C</sub> = 25 °C, unless otherwise specified)

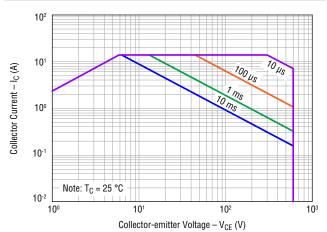
Powemeter (T = 25 °C)	Symbol	Conditions	Value			Unit
Parameter (T <sub>C</sub> = 25 °C)	Symbol	Min.	Тур.	Max.	Onit	
Reverse Recovery Time	t <sub>rr</sub>	$dI_F/dt = 200 A/\mu s$	_	40	_	ns
Reverse Recovery Charge	Q <sub>rr</sub>	$I_F = 5.0 \text{ A}$	_	80	_	nC

### **Electrical Characteristic Performance**

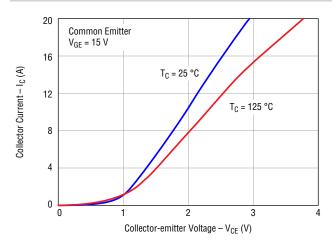
### **Typical Output Characteristics**



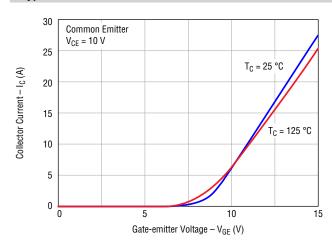
### Forward Bias Safe Operating Area



### **Typical Saturation Voltage Characteristics**

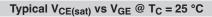


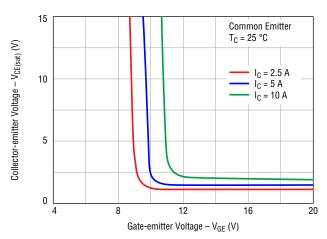
### **Typical Transfer Characteristics**



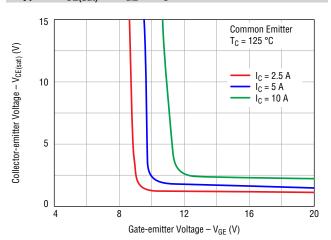
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### **Electrical Characteristic Performance (continued)**

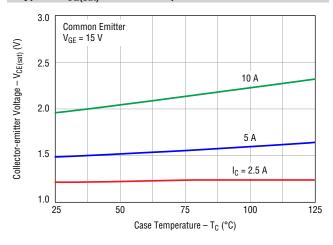




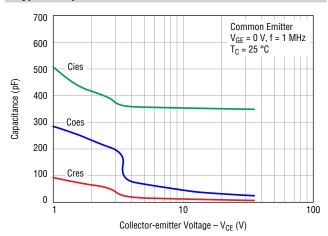
### Typical V<sub>CE(sat)</sub> vs V<sub>GE</sub> @ T<sub>C</sub> = 125 °C



### Typical V<sub>CE(sat)</sub> vs Case Temperature



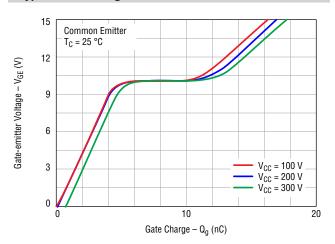
### **Typical Capacitance Characteristics**



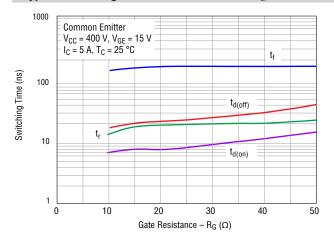
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### **Electrical Characteristic Performance (continued)**

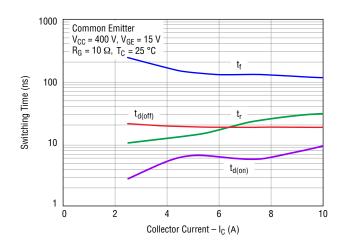
### **Typical Gate Charge Characteristic**



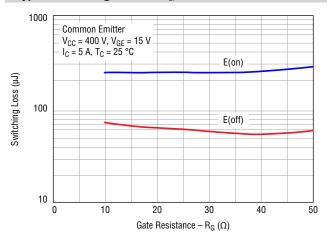
### Typical Switching Time Characteristics vs R<sub>G</sub>



### Typical Switching Time Characteristics vs I<sub>C</sub>

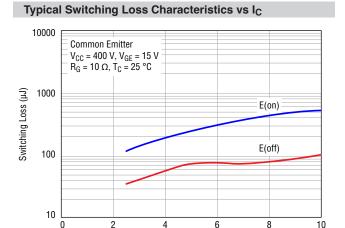


### Typical Switching Loss vs R<sub>G</sub>

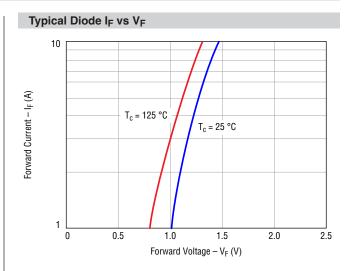


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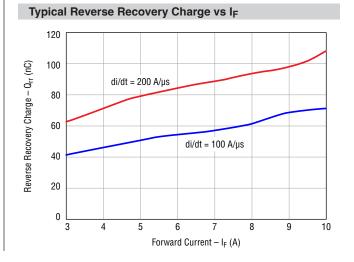
### **Electrical Characteristic Performance (continued)**



Collector Current - I<sub>C</sub> (A)

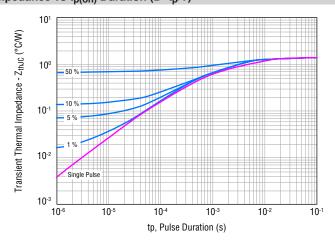


# Typical Reverse Recovery Time vs I<sub>F</sub> 60 60 di/dt = 100 A/μs di/dt = 200 A/μs 30 20 3 4 5 6 7 8 9 10 Forward Current – I<sub>F</sub> (A)

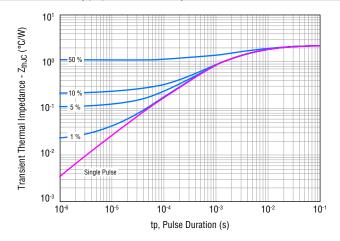


### **Electrical Characteristic Performance (continued)**

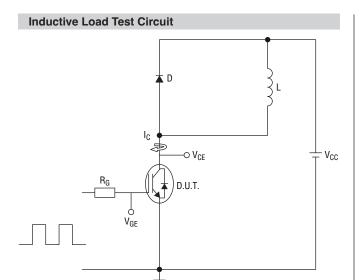
### IGBT Transient Thermal Impedance vs tp(on) Duration (D=tp/T)



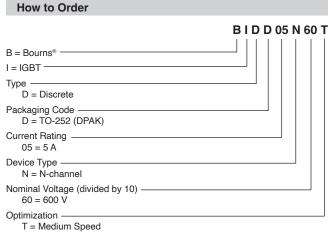
### Diode Transient Thermal Impedance vs $t_{p(on)}$ Duration (D= $t_p$ /T)



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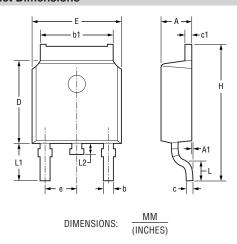


L=11.2 mH,  $V_{CE}=400$  V,  $V_{GE}=15$  V,  $I_{C}=5$  A,  $R_{G}=10~\Omega$ 



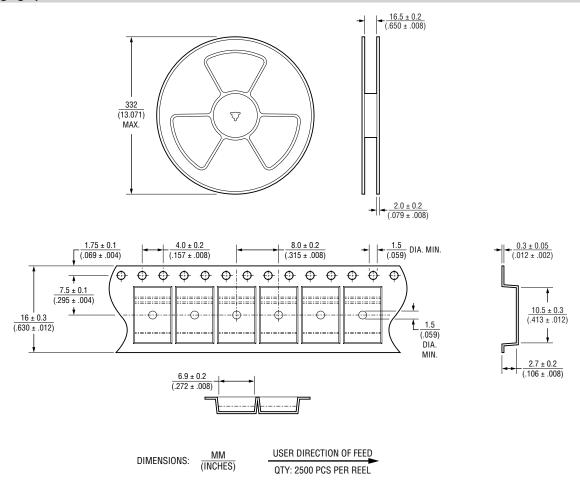
### **Environmental Characteristics**

### **Product Dimensions**



Symbol	Min.	Nom.	Max.		
А	2.10	2.30	2.50		
	(.083)	(.091)	(.098)		
A1	0	_	<u>0.127</u> (.005)		
b	0.66	0.76	0.89		
	(.026)	(.030)	(.035)		
b1	5.10	5.33	5.46		
	(.201)	(.210)	(.215)		
С	0.45 (.018)	_	0.65 (.026)		
c1	0.45 (.018)	_	0.65 (.026)		
D	5.80	6.10	6.40		
	(.228)	(.240)	(.252)		
Е	6.30	6.60	6.90		
	(.248)	(.260)	(.272)		
е	2.30 (.091) TYP				
Н	9.60	10.10	10.60		
	(.378)	(.398)	(.417)		
L	1.40	1.50	1.70		
	(.055)	(.059)	(.067)		
L1	2.90 (.114) REF				
L2	0.60	0.80	1.00		
	(.024)	(.031)	(.039)		

### **Packaging Specifications**



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